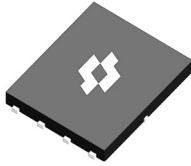
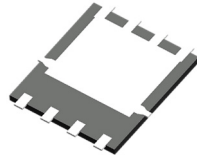


Product Summary

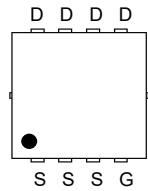
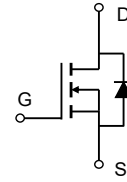
V_{DS}	$R_{DS(ON)_TYP}$	I_{D_MAX}
30 V	0.8 m Ω @ $V_{GS} = 10V$	254 A
	1.2 m Ω @ $V_{GS} = 4.5V$	

PDFN5060-8L


Top View



Bottom View


 PIN Configuration
(Top View)


Schematic Diagram

Features

- Ultra-low On-Resistance
- Excellent FoM (figure of merit)
- 100% ΔV_{DS} & UIS & R_g Tested


Applications

- Motor Drive
- Li- Battery Protection
- High-performance DC-DC Converters

Mechanical Data

- Green Molding Compound
- Moisture Sensitivity: Level 1 per J-STD-020
- UL Flammability Classification Rating 94V-0

Ordering Information

Orderable Part Number	Package Type	Device Marking	Form	Quantity (pcs)
SMT3001GLP	PDFN5060-8L	3001GL	13" Tape&Reel	5,000

Maximum Ratings (@ $T_C = 25^\circ\text{C}$, unless otherwise specified.)

Parameter	Symbol	Value	Unit
Drain - Source Voltage	V_{DS}	30	V
Gate - Source Voltage	V_{GS}	± 20	V
Continuous Drain Current ($V_{GS} = 10V$) ⁽¹⁾	I_D	254	A
		161	A
Pulsed Drain Current ⁽²⁾	I_{DM}	1017	A
Single Pulse Avalanche Energy ⁽³⁾	E_{AS}	578	mJ
Single Pulse Avalanche Current ($L = 0.1mH$)	I_{AS}	63	A
Power Dissipation	P_D	96	W
		38	W
Junction & Storage Temperature Range	T_J, T_{STG}	-55 ~ +150	$^\circ\text{C}$

Thermal Characteristics

Parameter	Symbol	Typ.	Max.	Unit
Thermal Resistance, Junction-to-Ambient ⁽⁴⁾	$R_{\theta JA}$	35	45	$^\circ\text{C/W}$
Thermal Resistance, Junction-to-Case ⁽⁵⁾	$R_{\theta JC}$	1.0	1.3	$^\circ\text{C/W}$

Electrical Characteristics (@ $T_J = 25^\circ\text{C}$, unless otherwise specified.)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Off Characteristics ⁽⁶⁾						
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = 250μA	30	-	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 30V, V _{GS} = 0V	-	-	1.0	μA
		T _J = 125°C	-	-	100	μA
Gate-Source Leakage Current	I _{GSS}	V _{GS} = ±20V, V _{DS} = 0V	-	-	±100	nA
On Characteristics ⁽⁶⁾						
Gate Threshold Voltage	V _{GS(th)}	V _{GS} = V _{DS} , I _D = 250μA	1.2	1.7	2.5	V
Static Drain-Source On-Resistance	R _{DS(ON)}	V _{GS} = 10V, I _D = 20A	-	0.8	1.0	mΩ
		V _{GS} = 4.5V, I _D = 15A	-	1.2	1.6	mΩ
Forward Transconductance	g _{fs}	V _{DS} = 5.0V, I _D = 20A	-	60	-	S
Diodes Forward Voltage	V _{SD}	I _S = 2.0A, V _{GS} = 0V	-	0.7	1.2	V
Dynamic Characteristics ⁽⁷⁾						
Input Capacitance	C _{iss}	V _{DS} = 15V, V _{GS} = 0V, f = 1MHz	-	3535	-	pF
Output Capacitance	C _{oss}		-	1829	-	pF
Reverse Transfer Capacitance	C _{rss}		-	100	-	pF
Gate Resistance	R _g	V _{GS} = 0V, V _{DS} = 0V, f = 1MHz	-	0.8	-	Ω
Switching Characteristics ⁽⁷⁾						
Turn-On DelayTime	t _{d(on)}	V _{GS} = 10V, V _{DS} = 15V I _D = 20A, R _{GEN} = 3.0Ω	-	6.0	-	ns
Rise Time	t _r		-	15.1	-	ns
Turn-Off DelayTime	t _{d(off)}		-	33	-	ns
Fall Time	t _f		-	14.5	-	ns
Gate Charge Characteristics ⁽⁷⁾						
Total Gate Charge (V _{GS} = 10V)	Q _g	V _{DS} = 15V, I _D = 20A V _{GS} = 10V	-	52	-	nC
Total Gate Charge (V _{GS} = 4.5V)	Q _g		-	23	-	nC
Gate-Source Charge	Q _{gs}		-	8.5	-	nC
Gate-Drain Charge	Q _{gd}		-	6.3	-	nC
Gate Plateau Voltage	V _{plateau}		-	2.6	-	V
Drain-Source Diode Characteristics ⁽⁷⁾						
Body Diode Reverse Recovery Time	t _{rr}	I _F = 20A, dI/dt = 100A/μs, T _J = 25°C	-	47	-	ns
Body Diode Reverse Recovery Charge	Q _{rr}		-	39	-	nC
Diode Forward Current	I _S	T _C = 25°C	-	-	63	A

Notes:

1. This current is chip limited, which is calculated based on R_{thjc} .
2. This current is calculated on single pulse with 10 μs Single Pulse.
3. Defined by design, not subject to production test, E_{AS} condition: $T_J=25^\circ\text{C}$, $V_{DD}=15V$, $V_{GS}=10V$, $L=1.0\text{mH}$.
4. Device mounted on FR-4 substrate PC board with 2oz copper in 1inch square cooling area.
5. Thermal resistance from junction to the exposed pad.
6. Short duration pulse test used to minimize self-heating effect.
7. Defined by design, not subject to production.

Typical Electrical and Thermal Characteristics

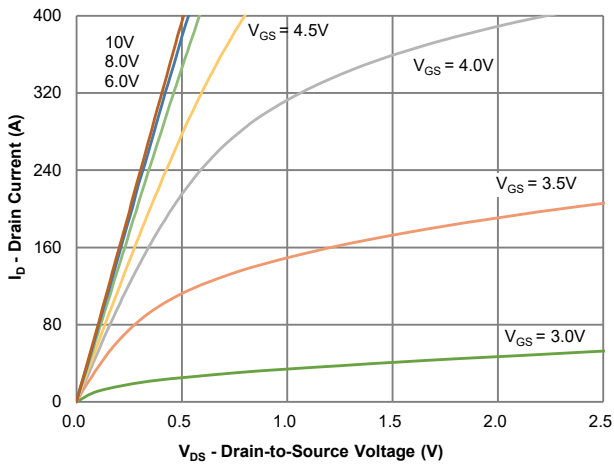


Figure 1: Output Characteristics

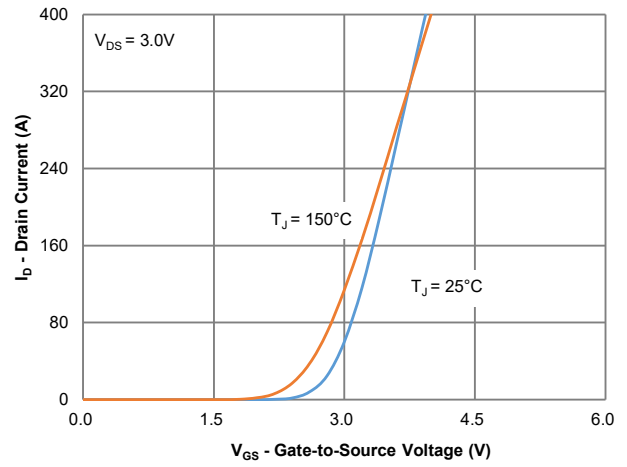


Figure 2: Transfer Characteristics

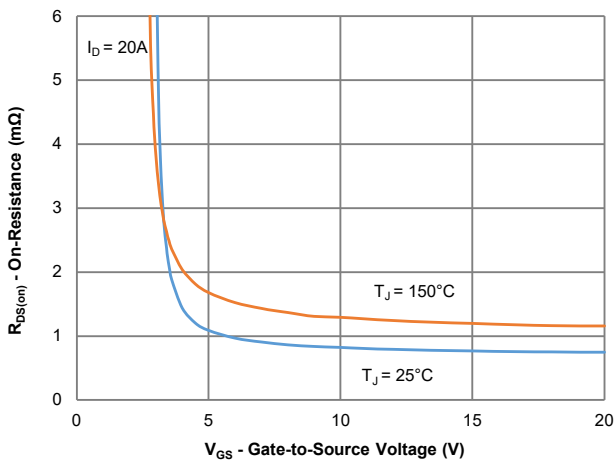


Figure 3: On-Resistance vs. Gate-Source Voltage

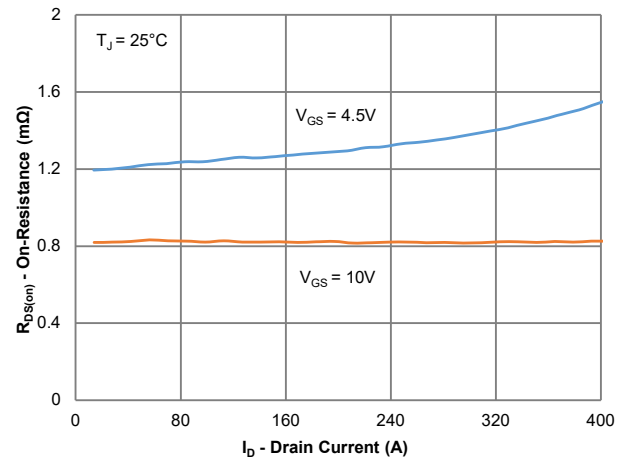


Figure 4: On-Resistance vs. Drain Current and Gate Voltage

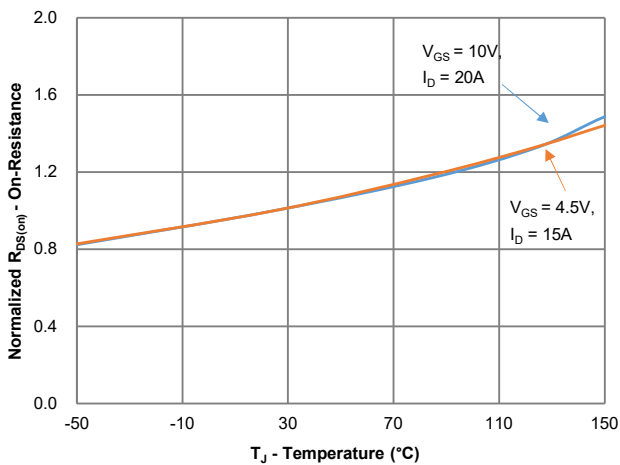


Figure 5: On-Resistance vs. Junction Temperature

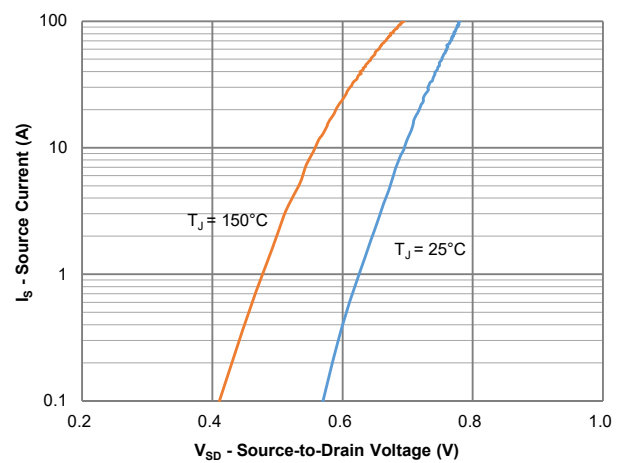


Figure 6: Source-Drain Diode Forward Voltage

Typical Electrical and Thermal Characteristics

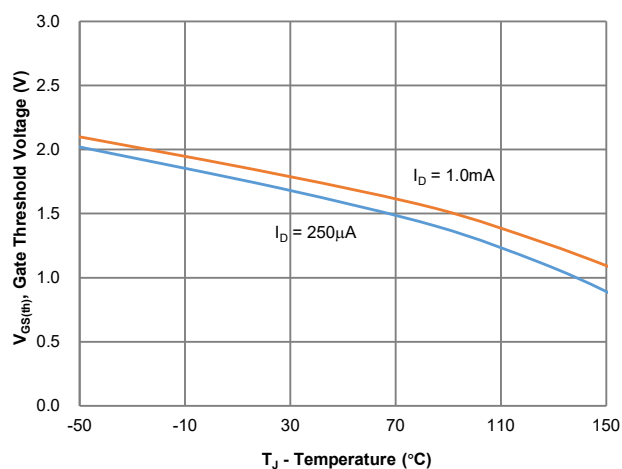


Figure 7: Gate Threshold Variation vs. Junction Temperature

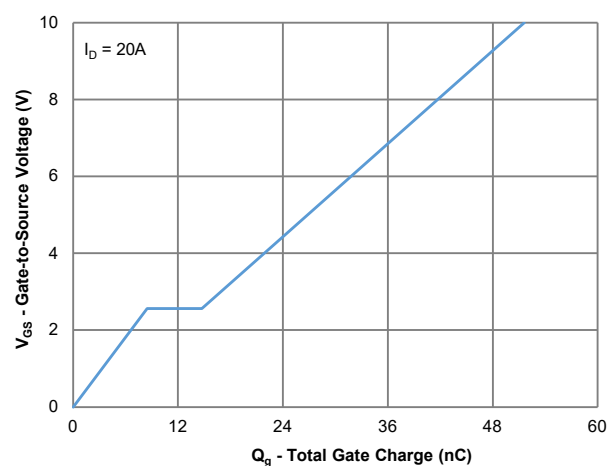


Figure 8: Gate Charge Characteristics

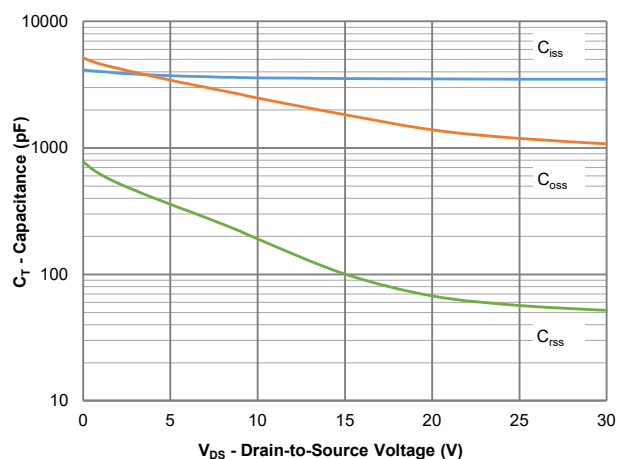


Figure 9: Capacitance Characteristics

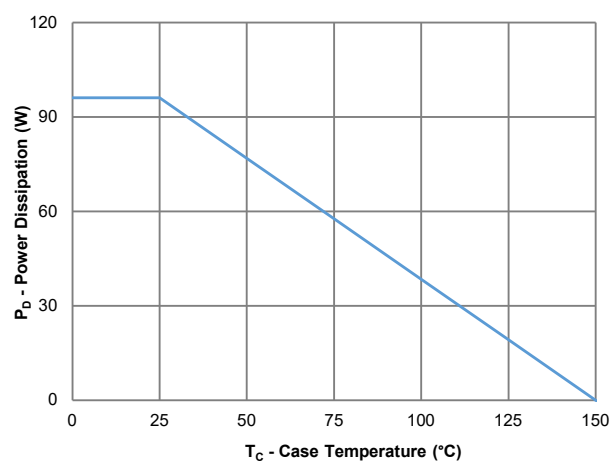


Figure 10: Power Derating

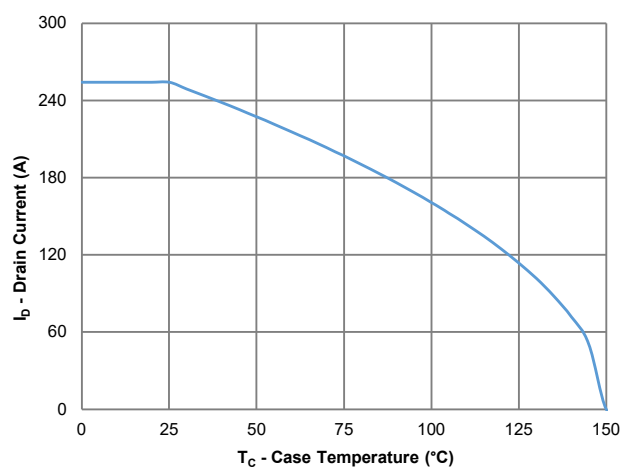


Figure 11: Current Derating

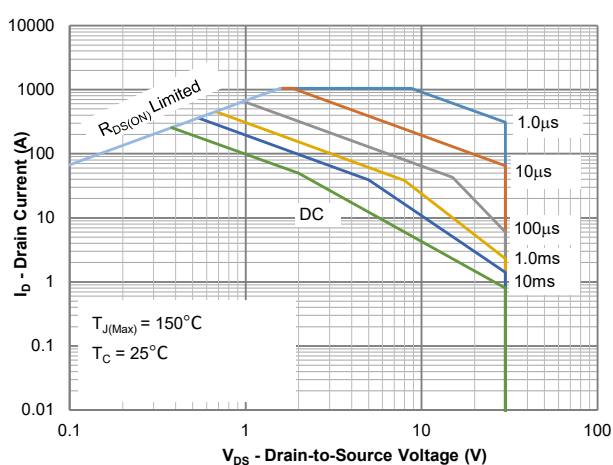


Figure 12: Safe Operating Area

Typical Electrical and Thermal Characteristics

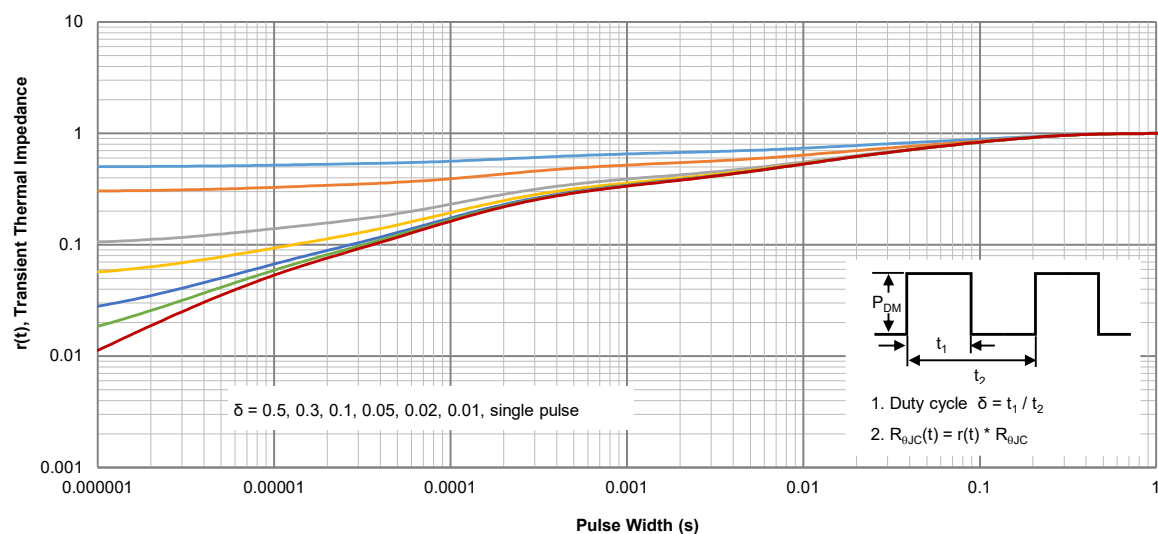
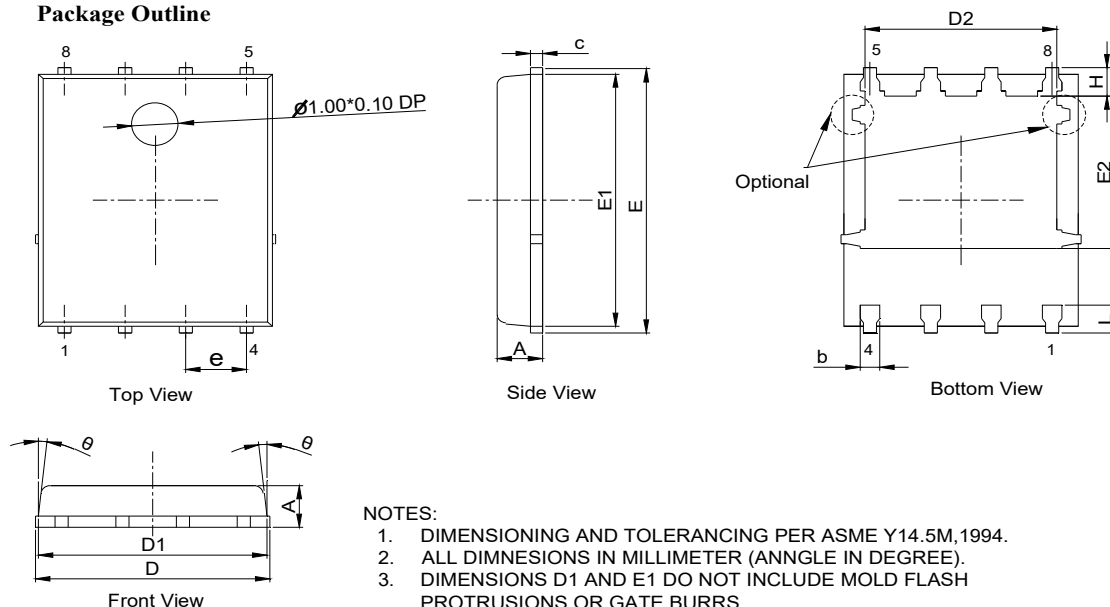
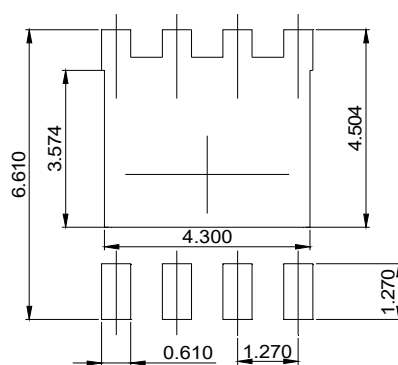


Figure 13: Normalized Maximum Transient Thermal Impedance

Package Outline

NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. ALL DIMENSIONS IN MILLIMETER (ANGLE IN DEGREE).
3. DIMENSIONS $D1$ AND $E1$ DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS.

DIM.	MILLIMETER		
	MIN.	NOM.	MAX.
A	0.90	1.00	1.10
b	0.20	--	0.51
c	0.21	0.25	0.34
D	4.90	--	5.40
D1	4.80	--	5.15
D2	3.70	--	4.20
E	5.90	--	6.50
E1	5.65	5.80	5.95
E2	3.32	3.50	3.63
e	1.27BSC		
H	0.50	--	0.93
L	0.45	--	0.91
θ	0°	--	12°

Recommended Soldering Footprint


DIMENSIONS: MILLIMETERS